



Sheet 1 of 1

Form PTO-129
(REV. 8-83)US Dept. of Commerce
PATENT & TRADEMARK OFFICEATTY DOCKET NO.
111673APPLICATION NO.
10/030,822

INFORMATION DISCLOSURE STATEMENT

(Use several sheets if necessary)

APPLICANT(S)
Takashi AOKI et al.FILING DATE
January 16, 2002GROUP
2851

U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS
RA	US 2002/0145711 A1	10-10-2002	Magome et al.		
RA	US 2002/0057422 A1	05-16-2002	Arakawa		
RA	US 2003/0006380 A1	01-09-2003	Van Empel et al.		
RA	4,704,348	11-03-1987	Koizumi et al.		
RA	4,801,352	01-31-1989	Piwczyk		
RA	5,025,284	06-18-1991	Komoriya et al.		
RA	5,087,927	02-11-1992	Thomas et al.		
RA	5,103,102	04-07-1992	Economou et al.		
RA	5,559,584	09-24-1996	Miyaji et al.		
RA	5,877,843	03-02-1999	Takagi et al.		
RA	5,973,764	10-26-1999	McCullough et al.		
RA	5,997,963	12-07-1999	Davison et al.		
RA	6,208,406 B1	03-27-2001	Nakashima		
RA	6,313,953 B1	11-06-2001	Dallas		
RA	6,538,716 B2	03-25-2003	Mulkens et al.		
RA	6,731,371 B1	05-04-2004	Shiraishi		

FOREIGN PATENT DOCUMENTS

DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB CLASS
EP 1 098 225 A2	05-09-2001	Europe		
WO 01/06548 A1	01-25-2001	WIPO		
WO 01/84241 A1	11-08-2001	WIPO		

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)

EXAMINER		DATE CONSIDERED 8-19-08
Examiner: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.		

Date: May 12, 2004



Duplicate

*of 1449
data June 2, 2004*

Sheet 1 of 1

Form PTO-1449 (REV. 8-83)		US Dept. of Commerce PATENT & TRADEMARK OFFICE		ATTY DOCKET NO. 111673		APPLICATION NO. 10/030,822	
INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary)				APPLICANT(S) Takashi AOKI et al.			
				FILING DATE January 16, 2002		GROUP 2851	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	
		US 2002/0145711 A1	10-10-2002	Magome et al.			
		US 2002/0057422 A1	05-16-2002	Arakawa			
		US 2003/0006380 A1	01-09-2003	Van Empel et al.			
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		5,973,764	10-26-1999	McCullough et al.			
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EXAMINER					DATE CONSIDERED		
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